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## Understanding <u>Embedded - FPGAs (Field Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

#### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

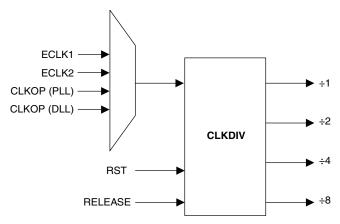
Details	
Product Status	Obsolete
Number of LABs/CLBs	18625
Number of Logic Elements/Cells	149000
Total RAM Bits	7014400
Number of I/O	586
Number of Gates	-
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	1156-BBGA
Supplier Device Package	1156-FPBGA (35x35)
Purchase URL	https://www.e-xfl.com/product-detail/lattice-semiconductor/lfe3-150ea-7fn1156ctw

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong



Figure 2-8. Clock Divider Connections



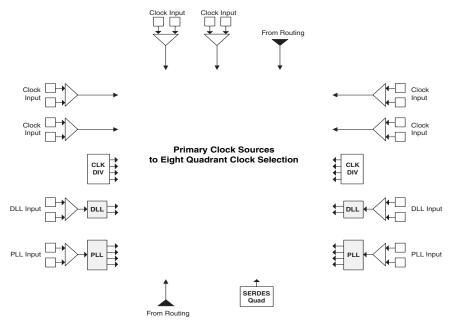
#### **Clock Distribution Network**

LatticeECP3 devices have eight quadrant-based primary clocks and eight secondary clock/control sources. Two high performance edge clocks are available on the top, left, and right edges of the device to support high speed interfaces. These clock sources are selected from external I/Os, the sysCLOCK PLLs, DLLs or routing. These clock sources are fed throughout the chip via a clock distribution system.

#### **Primary Clock Sources**

LatticeECP3 devices derive clocks from six primary source types: PLL outputs, DLL outputs, CLKDIV outputs, dedicated clock inputs, routing and SERDES Quads. LatticeECP3 devices have two to ten sysCLOCK PLLs and two DLLs, located on the left and right sides of the device. There are six dedicated clock inputs: two on the top side, two on the left side and two on the right side of the device. Figures 2-9, 2-10 and 2-11 show the primary clock sources for LatticeECP3 devices.

Figure 2-9. Primary Clock Sources for LatticeECP3-17



Note: Clock inputs can be configured in differential or single-ended mode



#### Single, Dual and Pseudo-Dual Port Modes

In all the sysMEM RAM modes the input data and address for the ports are registered at the input of the memory array. The output data of the memory is optionally registered at the output.

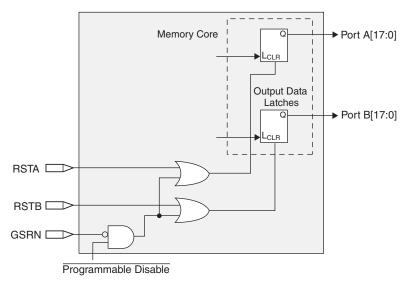
EBR memory supports the following forms of write behavior for single port or dual port operation:

- 1. **Normal** Data on the output appears only during a read cycle. During a write cycle, the data (at the current address) does not appear on the output. This mode is supported for all data widths.
- 2. **Write Through** A copy of the input data appears at the output of the same port during a write cycle. This mode is supported for all data widths.
- 3. **Read-Before-Write (EA devices only)** When new data is written, the old content of the address appears at the output. This mode is supported for x9, x18, and x36 data widths.

#### **Memory Core Reset**

The memory array in the EBR utilizes latches at the A and B output ports. These latches can be reset asynchronously or synchronously. RSTA and RSTB are local signals, which reset the output latches associated with Port A and Port B, respectively. The Global Reset (GSRN) signal can reset both ports. The output data latches and associated resets for both ports are as shown in Figure 2-22.

Figure 2-22. Memory Core Reset



For further information on the sysMEM EBR block, please see the list of technical documentation at the end of this data sheet.

#### sysDSP™ Slice

The LatticeECP3 family provides an enhanced sysDSP architecture, making it ideally suited for low-cost, high-performance Digital Signal Processing (DSP) applications. Typical functions used in these applications are Finite Impulse Response (FIR) filters, Fast Fourier Transforms (FFT) functions, Correlators, Reed-Solomon/Turbo/Convolution encoders and decoders. These complex signal processing functions use similar building blocks such as multiply-adders and multiply-accumulators.

#### sysDSP Slice Approach Compared to General DSP

Conventional general-purpose DSP chips typically contain one to four (Multiply and Accumulate) MAC units with fixed data-width multipliers; this leads to limited parallelism and limited throughput. Their throughput is increased by higher clock speeds. The LatticeECP3, on the other hand, has many DSP slices that support different data widths.



#### **MULTADDSUBSUM DSP Element**

In this case, the operands AA and AB are multiplied and the result is added/subtracted with the result of the multiplier operation of operands BA and BB of Slice 0. Additionally, the operands AA and AB are multiplied and the result is added/subtracted with the result of the multiplier operation of operands BA and BB of Slice 1. The results of both addition/subtractions are added by the second ALU following the slice cascade path. The user can enable the input, output and pipeline registers. Figure 2-30 and Figure 2-31 show the MULTADDSUBSUM sysDSP element

Figure 2-30. MULTADDSUBSUM Slice 0

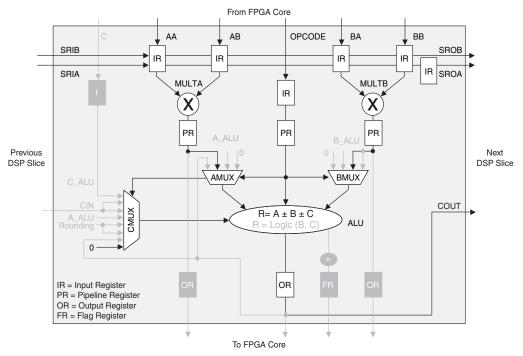
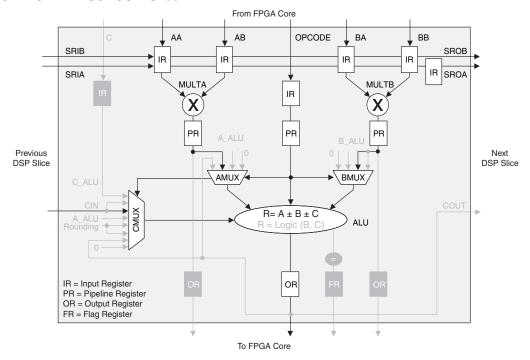




Figure 2-31. MULTADDSUBSUM Slice 1



#### **Advanced sysDSP Slice Features**

#### Cascading

The LatticeECP3 sysDSP slice has been enhanced to allow cascading. Adder trees are implemented fully in sys-DSP slices, improving the performance. Cascading of slices uses the signals CIN, COUT and C Mux of the slice.

#### **Addition**

The LatticeECP3 sysDSP slice allows for the bypassing of multipliers and cascading of adder logic. High performance adder functions are implemented without the use of LUTs. The maximum width adders that can be implemented are 54-bit.

#### Rounding

The rounding operation is implemented in the ALU and is done by adding a constant followed by a truncation operation. The rounding methods supported are:

- · Rounding to zero (RTZ)
- Rounding to infinity (RTI)
- · Dynamic rounding
- · Random rounding
- · Convergent rounding



#### **ALU Flags**

The sysDSP slice provides a number of flags from the ALU including:

- Equal to zero (EQZ)
- Equal to zero with mask (EQZM)
- Equal to one with mask (EQOM)
- · Equal to pattern with mask (EQPAT)
- Equal to bit inverted pattern with mask (EQPATB)
- · Accumulator Overflow (OVER)
- Accumulator Underflow (UNDER)
- Either over or under flow supporting LatticeECP2 legacy designs (OVERUNDER)

#### **Clock, Clock Enable and Reset Resources**

Global Clock, Clock Enable and Reset signals from routing are available to every sysDSP slice. From four clock sources (CLK0, CLK1, CLK2, and CLK3) one clock is selected for each input register, pipeline register and output register. Similarly Clock Enable (CE) and Reset (RST) are selected at each input register, pipeline register and output register.

#### Resources Available in the LatticeECP3 Family

Table 2-9 shows the maximum number of multipliers for each member of the LatticeECP3 family. Table 2-10 shows the maximum available EBR RAM Blocks in each LatticeECP3 device. EBR blocks, together with Distributed RAM can be used to store variables locally for fast DSP operations.

Table 2-9. Maximum Number of DSP Slices in the LatticeECP3 Family

Device	DSP Slices	9x9 Multiplier	18x18 Multiplier	36x36 Multiplier
ECP3-17	12	48	24	6
ECP3-35	32	128	64	16
ECP3-70	64	256	128	32
ECP3-95	64	256	128	32
ECP3-150	160	640	320	80

Table 2-10. Embedded SRAM in the LatticeECP3 Family

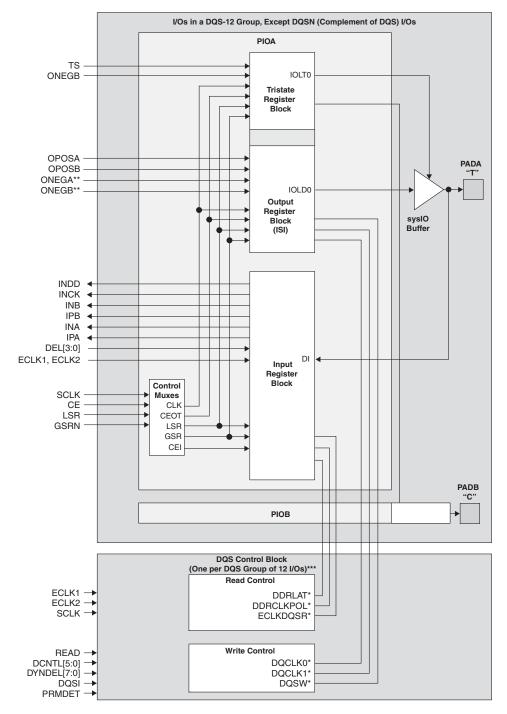
Device	EBR SRAM Block	Total EBR SRAM (Kbits)
ECP3-17	38	700
ECP3-35	72	1327
ECP3-70	240	4420
ECP3-95	240	4420
ECP3-150	372	6850



### Programmable I/O Cells (PIC)

Each PIC contains two PIOs connected to their respective sysl/O buffers as shown in Figure 2-32. The PIO Block supplies the output data (DO) and the tri-state control signal (TO) to the sysl/O buffer and receives input from the buffer. Table 2-11 provides the PIO signal list.

Figure 2-32. PIC Diagram



<sup>\*</sup> Signals are available on left/right/top edges only.

<sup>\*\*</sup> Signals are available on the left and right sides only

<sup>\*\*\*</sup> Selected PIO.



Two adjacent PIOs can be joined to provide a differential I/O pair (labeled as "T" and "C") as shown in Figure 2-32. The PAD Labels "T" and "C" distinguish the two PIOs. Approximately 50% of the PIO pairs on the left and right edges of the device can be configured as true LVDS outputs. All I/O pairs can operate as LVDS inputs.

Table 2-11. PIO Signal List

Name	Туре	Description
INDD	Input Data	Register bypassed input. This is not the same port as INCK.
IPA, INA, IPB, INB	Input Data	Ports to core for input data
OPOSA, ONEGA <sup>1</sup> , OPOSB, ONEGB <sup>1</sup>	Output Data	Output signals from core. An exception is the ONEGB port, used for tristate logic at the DQS pad.
CE	PIO Control	Clock enables for input and output block flip-flops.
SCLK	PIO Control	System Clock (PCLK) for input and output/TS blocks. Connected from clock ISB.
LSR	PIO Control	Local Set/Reset
ECLK1, ECLK2	PIO Control	Edge clock sources. Entire PIO selects one of two sources using mux.
ECLKDQSR <sup>1</sup>	Read Control	From DQS_STROBE, shifted strobe for memory interfaces only.
DDRCLKPOL <sup>1</sup>	Read Control	Ensures transfer from DQS domain to SCLK domain.
DDRLAT <sup>1</sup>	Read Control	Used to guarantee INDDRX2 gearing by selectively enabling a D-Flip-Flop in datapath.
DEL[3:0]	Read Control	Dynamic input delay control bits.
INCK	To Clock Distribution and PLL	PIO treated as clock PIO, path to distribute to primary clocks and PLL.
TS	Tristate Data	Tristate signal from core (SDR)
DQCLK0 <sup>1</sup> , DQCLK1 <sup>1</sup>	Write Control	Two clocks edges, 90 degrees out of phase, used in output gearing.
DQSW <sup>2</sup>	Write Control	Used for output and tristate logic at DQS only.
DYNDEL[7:0]	Write Control	Shifting of write clocks for specific DQS group, using 6:0 each step is approximately 25ps, 128 steps. Bit 7 is an invert (timing depends on input frequency). There is also a static control for this 8-bit setting, enabled with a memory cell.
DCNTL[6:0]	PIO Control	Original delay code from DDR DLL
DATAVALID <sup>1</sup>	Output Data	Status flag from DATAVALID logic, used to indicate when input data is captured in IOLOGIC and valid to core.
READ	For DQS_Strobe	Read signal for DDR memory interface
DQSI	For DQS_Strobe	Unshifted DQS strobe from input pad
PRMBDET	For DQS_Strobe	DQSI biased to go high when DQSI is tristate, goes to input logic block as well as core logic.
GSRN	Control from routing	Global Set/Reset

<sup>1.</sup> Signals available on left/right/top edges only.

#### PIO

The PIO contains four blocks: an input register block, output register block, tristate register block and a control logic block. These blocks contain registers for operating in a variety of modes along with the necessary clock and selection logic.

#### **Input Register Block**

The input register blocks for the PIOs, in the left, right and top edges, contain delay elements and registers that can be used to condition high-speed interface signals, such as DDR memory interfaces and source synchronous interfaces, before they are passed to the device core. Figure 2-33 shows the input register block for the left, right and top edges. The input register block for the bottom edge contains one element to register the input signal and no DDR registers. The following description applies to the input register block for PIOs in the left, right and top edges only.

<sup>2.</sup> Selected PIO.



#### **DC Electrical Characteristics**

Symbol	Parameter	Condition	Min.	Тур.	Max.	Units
I <sub>IL</sub> , I <sub>IH</sub> <sup>1, 4</sup>	Input or I/O Low Leakage	$0 \le V_{IN} \le (V_{CCIO} - 0.2 \text{ V})$	_	_	10	μΑ
I <sub>IH</sub> <sup>1, 3</sup>	Input or I/O High Leakage	$(V_{CCIO} - 0.2 \text{ V}) < V_{IN} \le 3.6 \text{ V}$	_	_	150	μΑ
I <sub>PU</sub>	I/O Active Pull-up Current	$0 \le V_{IN} \le 0.7 \ V_{CCIO}$	-30	_	-210	μΑ
$I_{PD}$	I/O Active Pull-down Current	$V_{IL} (MAX) \le V_{IN} \le V_{CCIO}$	30	_	210	μΑ
I <sub>BHLS</sub>	Bus Hold Low Sustaining Current	$V_{IN} = V_{IL} (MAX)$	30	_	_	μΑ
I <sub>BHHS</sub>	Bus Hold High Sustaining Current	$V_{IN} = 0.7 V_{CCIO}$	-30	_	_	μΑ
I <sub>BHLO</sub>	Bus Hold Low Overdrive Current	$0 \le V_{IN} \le V_{CCIO}$	_	_	210	μΑ
I <sub>BHHO</sub>	Bus Hold High Overdrive Current	$0 \le V_{IN} \le V_{CCIO}$	_	_	-210	μΑ
$V_{BHT}$	Bus Hold Trip Points	$0 \le V_{IN} \le V_{IH} (MAX)$	$V_{IL}$ (MAX)	_	V <sub>IH</sub> (MIN)	>
C1	I/O Capacitance <sup>2</sup>	$V_{CCIO} = 3.3 \text{ V}, 2.5 \text{ V}, 1.8 \text{ V}, 1.5 \text{ V}, 1.2 \text{ V}, V_{CC} = 1.2 \text{ V}, V_{IO} = 0 \text{ to } V_{IH} \text{ (MAX)}$	_	5	8	pf
C2	Dedicated Input Capacitance <sup>2</sup>	$V_{CCIO} = 3.3 \text{ V}, 2.5 \text{ V}, 1.8 \text{ V}, 1.5 \text{ V}, 1.2 \text{ V}, V_{CC} = 1.2 \text{ V}, V_{IO} = 0 \text{ to } V_{IH} \text{ (MAX)}$	_	5	7	pf

<sup>1.</sup> Input or I/O leakage current is measured with the pin configured as an input or as an I/O with the output driver tri-stated. It is not measured with the output driver active. Bus maintenance circuits are disabled.

<sup>2.</sup>  $T_A$  25 °C, f = 1.0 MHz.

Applicable to general purpose I/Os in top and bottom banks.
 When used as V<sub>REF</sub> maximum leakage= 25 μA.



# LatticeECP3 Supply Current (Standby)<sup>1, 2, 3, 4, 5, 6</sup>

			Турі	ical	
Symbol	Parameter	Device	-6L, -7L, -8L	-6, -7, -8	Units
		ECP-17EA	29.8	49.4	mA
		ECP3-35EA	53.7	89.4	mA
I <sub>CC</sub>	Core Power Supply Current	ECP3-70EA	137.3	230.7	mA
		ECP3-95EA	137.3	230.7	mA
		ECP3-150EA	219.5	370.9	mA
		ECP-17EA	18.3	19.4	mA
		ECP3-35EA	19.6	23.1	mA
I <sub>CCAUX</sub>	Auxiliary Power Supply Current	ECP3-70EA	26.5	32.4	mA
		ECP3-95EA	26.5	32.4	mA
		ECP3-150EA	37.0	45.7	mA
		ECP-17EA	0.0	0.0	mA
		ECP3-35EA	0.1	0.1	mA
I <sub>CCPLL</sub>	PLL Power Supply Current (Per PLL)	ECP3-70EA	0.1	0.1	mA
		ECP3-95EA	0.1	0.1	mA
		ECP3-150EA	0.1	0.1	mA
		ECP-17EA	1.3	1.4	mA
		ECP3-35EA	1.3	1.4	mA
I <sub>CCIO</sub>	Bank Power Supply Current (Per Bank)	ECP3-70EA	1.4	1.5	mA
		ECP3-95EA	1.4	1.5	mA
		ECP3-150EA	1.4	1.5	mA
I <sub>CCJ</sub>	JTAG Power Supply Current	All Devices	2.5	2.5	mA
		ECP-17EA	6.1	6.1	mA
		ECP3-35EA	6.1	6.1	mA
$I_{CCA}$	Transmit, Receive, PLL and Reference Clock Buffer Power Supply	ECP3-70EA	18.3	18.3	mA
	Tree crock Bullet I ower ouppry	ECP3-95EA	18.3	18.3	mA
		ECP3-150EA	24.4	24.4	mA

<sup>1.</sup> For further information on supply current, please see the list of technical documentation at the end of this data sheet.

<sup>2.</sup> Assumes all outputs are tristated, all inputs are configured as LVCMOS and held at the  $V_{\mbox{\scriptsize CCIO}}$  or GND.

<sup>3.</sup> Frequency 0 MHz.

<sup>4.</sup> Pattern represents a "blank" configuration data file.

<sup>5.</sup>  $T_J = 85$  °C, power supplies at nominal voltage.

<sup>6.</sup> To determine the LatticeECP3 peak start-up current data, use the Power Calculator tool.



# LatticeECP3 External Switching Characteristics (Continued)<sup>1, 2, 3, 13</sup>

#### **Over Recommended Commercial Operating Conditions**

			-8 -7		-7	-6			
Parameter	Description	Device	Min.	Max.	Min.	Max.	Min.	Max.	Units
t <sub>DVECLKGDDR</sub>	Data Hold After CLK	All ECP3EA Devices	0.775	_	0.775	_	0.775	_	UI
f <sub>MAX_GDDR</sub>	DDRX1 Clock Frequency	All ECP3EA Devices	_	250	_	250	_	250	MHz
Generic DDRX2 II	Generic DDRX2 Inputs with Clock and Data (>10 Bits Wide) Centered at Pin (GDDRX2_RX.ECLK.Centered) Using PCLK Pin for Clock input								
Left and Right Sig	des								
t <sub>SUGDDR</sub>	Data Setup Before CLK	ECP3-150EA	321	_	403	_	471	_	ps
t <sub>HOGDDR</sub>	Data Hold After CLK	ECP3-150EA	321	_	403	_	471	_	ps
f <sub>MAX_GDDR</sub>	DDRX2 Clock Frequency	ECP3-150EA		405	_	325	_	280	MHz
t <sub>SUGDDR</sub>	Data Setup Before CLK	ECP3-70EA/95EA	321	_	403	_	535	_	ps
t <sub>HOGDDR</sub>	Data Hold After CLK	ECP3-70EA/95EA	321	_	403	_	535	_	ps
f <sub>MAX_GDDR</sub>	DDRX2 Clock Frequency	ECP3-70EA/95EA	_	405	_	325	_	250	MHz
t <sub>SUGDDR</sub>	Data Setup Before CLK	ECP3-35EA	335	_	425	_	535	_	ps
t <sub>HOGDDR</sub>	Data Hold After CLK	ECP3-35EA	335	_	425	_	535	_	ps
f <sub>MAX_GDDR</sub>	DDRX2 Clock Frequency	ECP3-35EA	_	405	_	325	_	250	MHz
t <sub>SUGDDR</sub>	Data Setup Before CLK	ECP3-17EA	335	_	425	_	535	_	ps
t <sub>HOGDDR</sub>	Data Hold After CLK	ECP3-17EA	335	_	425	_	535	_	ps
f <sub>MAX GDDR</sub>	DDRX2 Clock Frequency	ECP3-17EA	_	405	_	325	_	250	MHz
Generic DDRX2 II	nputs with Clock and Data (>10	Bits Wide) Aligned at Pin	(GDDR)	(2_RX.E	CLK.Alig	ned)			ı
Left and Right Sig	de Using DLLCLKIN Pin for Cloc	k Input							
t <sub>DVACLKGDDR</sub>	Data Setup Before CLK	ECP3-150EA	_	0.225	_	0.225		0.225	UI
t <sub>DVECLKGDDR</sub>	Data Hold After CLK	ECP3-150EA	0.775	_	0.775	_	0.775	_	UI
f <sub>MAX_GDDR</sub>	DDRX2 Clock Frequency	ECP3-150EA	_	460	_	385		345	MHz
t <sub>DVACLKGDDR</sub>	Data Setup Before CLK	ECP3-70EA/95EA	_	0.225	_	0.225	_	0.225	UI
t <sub>DVECLKGDDR</sub>	Data Hold After CLK	ECP3-70EA/95EA	0.775	_	0.775		0.775	_	UI
f <sub>MAX_GDDR</sub>	DDRX2 Clock Frequency	ECP3-70EA/95EA	_	460	_	385	_	311	MHz
t <sub>DVACLKGDDR</sub>	Data Setup Before CLK	ECP3-35EA	_	0.210	_	0.210	_	0.210	UI
t <sub>DVECLKGDDR</sub>	Data Hold After CLK	ECP3-35EA	0.790	_	0.790	_	0.790	_	UI
f <sub>MAX_GDDR</sub>	DDRX2 Clock Frequency	ECP3-35EA	_	460	_	385	_	311	MHz
t <sub>DVACLKGDDR</sub>	Data Setup Before CLK	ECP3-17EA	_	0.210	_	0.210	_	0.210	UI
t <sub>DVECLKGDDR</sub>	Data Hold After CLK	ECP3-17EA	0.790	_	0.790	_	0.790	_	UI
f <sub>MAX GDDR</sub>	DDRX2 Clock Frequency	ECP3-17EA		460	_	385	_	311	MHz
_	CLK Pin for Clock Input								
t <sub>DVACLKGDDR</sub>	Data Setup Before CLK	ECP3-150EA	_	0.225	_	0.225	_	0.225	UI
t <sub>DVECLKGDDR</sub>	Data Hold After CLK	ECP3-150EA	0.775	_	0.775	_	0.775	_	UI
f <sub>MAX_GDDR</sub>	DDRX2 Clock Frequency	ECP3-150EA	_	235	_	170	_	130	MHz
t <sub>DVACLKGDDR</sub>	Data Setup Before CLK	ECP3-70EA/95EA	_	0.225	_	0.225	_	0.225	UI
t <sub>DVECLKGDDR</sub>	Data Hold After CLK	ECP3-70EA/95EA	0.775	_	0.775	_	0.775	_	UI
f <sub>MAX_GDDR</sub>	DDRX2 Clock Frequency	ECP3-70EA/95EA	_	235	_	170	_	130	MHz
t <sub>DVACLKGDDR</sub>	Data Setup Before CLK	ECP3-35EA		0.210	_	0.210	_	0.210	UI
t <sub>DVECLKGDDR</sub>	Data Hold After CLK	ECP3-35EA	0.790	_	0.790	_	0.790	_	UI
f <sub>MAX GDDR</sub>	DDRX2 Clock Frequency	ECP3-35EA	_	235	_	170	_	130	MHz
t <sub>DVACLKGDDR</sub>	Data Setup Before CLK	ECP3-17EA	_	0.210	_	0.210	_	0.210	UI
t <sub>DVECLKGDDR</sub>	Data Hold After CLK	ECP3-17EA	0.790	_	0.790	_	0.790	_	UI
f <sub>MAX_GDDR</sub>	DDRX2 Clock Frequency	ECP3-17EA	_	235	_	170	_	130	MHz



Table 3-7. Channel Output Jitter

Description	Frequency	Min.	Тур.	Max.	Units
Deterministic	3.125 Gbps	_	_	0.17	UI, p-p
Random	3.125 Gbps	_	_	0.25	UI, p-p
Total	3.125 Gbps	_	_	0.35	UI, p-p
Deterministic	2.5 Gbps	_	_	0.17	UI, p-p
Random	2.5 Gbps	_	_	0.20	UI, p-p
Total	2.5 Gbps	_	_	0.35	UI, p-p
Deterministic	1.25 Gbps	_	_	0.10	UI, p-p
Random	1.25 Gbps	_	_	0.22	UI, p-p
Total	1.25 Gbps	_	_	0.24	UI, p-p
Deterministic	622 Mbps	_	_	0.10	UI, p-p
Random	622 Mbps	_	_	0.20	UI, p-p
Total	622 Mbps	_	_	0.24	UI, p-p
Deterministic	250 Mbps	_	_	0.10	UI, p-p
Random	250 Mbps	_	_	0.18	UI, p-p
Total	250 Mbps	_	_	0.24	UI, p-p
Deterministic	150 Mbps	_	_	0.10	UI, p-p
Random	150 Mbps	_	_	0.18	UI, p-p
Total	150 Mbps	_	_	0.24	UI, p-p

Note: Values are measured with PRBS 2<sup>7</sup>-1, all channels operating, FPGA logic active, I/Os around SERDES pins quiet, reference clock @ 10X mode.



#### **SERDES High Speed Data Receiver**

Table 3-9. Serial Input Data Specifications

Symbol	Description		Min.	Тур.	Max.	Units
		3.125 G	_	_	136	
		2.5 G	_	_	144	
RX-CID <sub>S</sub>	Stream of nontransitions <sup>1</sup>	1.485 G	_	_	160	Bits
nx-cibs	(CID = Consecutive Identical Digits) @ 10 <sup>-12</sup> BER	622 M	_	_	204	Dita
		270 M	_	_	228	
		150 M	_	_	296	
V <sub>RX-DIFF-S</sub>	Differential input sensitivity		150	_	1760	mV, p-p
$V_{RX-IN}$	Input levels		0	_	V <sub>CCA</sub> +0.5 <sup>4</sup>	V
V <sub>RX-CM-DC</sub>	Input common mode range (DC coupled)		0.6	_	$V_{CCA}$	V
V <sub>RX-CM-AC</sub>	Input common mode range (AC coupled) <sup>3</sup>		0.1	_	V <sub>CCA</sub> +0.2	V
T <sub>RX-RELOCK</sub>	SCDR re-lock time <sup>2</sup>		_	1000	_	Bits
Z <sub>RX-TERM</sub>	Input termination 50/75 Ohm/High Z		-20%	50/75/HiZ	+20%	Ohms
RL <sub>RX-RL</sub>	Return loss (without package)		10	_	_	dB

<sup>1.</sup> This is the number of bits allowed without a transition on the incoming data stream when using DC coupling.

#### **Input Data Jitter Tolerance**

A receiver's ability to tolerate incoming signal jitter is very dependent on jitter type. High speed serial interface standards have recognized the dependency on jitter type and have specifications to indicate tolerance levels for different jitter types as they relate to specific protocols. Sinusoidal jitter is considered to be a worst case jitter type.

Table 3-10. Receiver Total Jitter Tolerance Specification

Description	Frequency	Condition	Min.	Тур.	Max.	Units
Deterministic		600 mV differential eye	_	_	0.47	UI, p-p
Random	3.125 Gbps	600 mV differential eye	_	_	0.18	UI, p-p
Total		600 mV differential eye	_	_	0.65	UI, p-p
Deterministic		600 mV differential eye	_	_	0.47	UI, p-p
Random	2.5 Gbps	600 mV differential eye	_	_	0.18	UI, p-p
Total		600 mV differential eye	_	_	0.65	UI, p-p
Deterministic		600 mV differential eye	_	_	0.47	UI, p-p
Random	1.25 Gbps	600 mV differential eye	_	_	0.18	UI, p-p
Total	7	600 mV differential eye	_	_	0.65	UI, p-p
Deterministic		600 mV differential eye	_	_	0.47	UI, p-p
Random	622 Mbps	600 mV differential eye	_	_	0.18	UI, p-p
Total	7	600 mV differential eye	_	_	0.65	UI, p-p

Note: Values are measured with CJPAT, all channels operating, FPGA Logic active, I/Os around SERDES pins quiet, voltages are nominal, room temperature.

<sup>2.</sup> This is the typical number of bit times to re-lock to a new phase or frequency within +/- 300 ppm, assuming 8b10b encoded data.

<sup>3.</sup> AC coupling is used to interface to LVPECL and LVDS. LVDS interfaces are found in laser drivers and Fibre Channel equipment. LVDS interfaces are generally found in 622 Mbps SERDES devices.

<sup>4.</sup> Up to 1.76 V.



Figure 3-16. Jitter Transfer – 1.25 Gbps

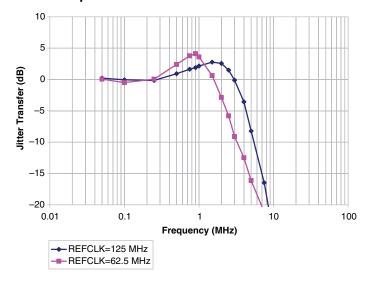
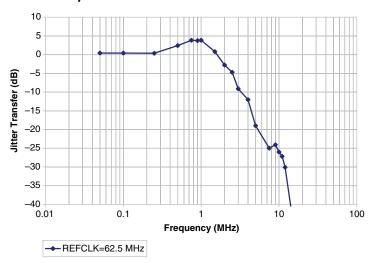


Figure 3-17. Jitter Transfer - 622 Mbps





# XAUI/Serial Rapid I/O Type 3/CPRI LV E.30 Electrical and Timing Characteristics

#### **AC and DC Characteristics**

Table 3-13. Transmit

#### **Over Recommended Operating Conditions**

Symbol	Description	Test Conditions	Min.	Тур.	Max.	Units
T <sub>RF</sub>	Differential rise/fall time	20%-80%	_	80	_	ps
Z <sub>TX_DIFF_DC</sub>	Differential impedance		80	100	120	Ohms
J <sub>TX_DDJ</sub> <sup>2, 3, 4</sup>	Output data deterministic jitter		_	_	0.17	UI
J <sub>TX_TJ</sub> <sup>1, 2, 3, 4</sup>	Total output data jitter		_	_	0.35	UI

- 1. Total jitter includes both deterministic jitter and random jitter.
- 2. Jitter values are measured with each CML output AC coupled into a 50-Ohm impedance (100-Ohm differential impedance).
- 3. Jitter and skew are specified between differential crossings of the 50% threshold of the reference signal.
- 4. Values are measured at 2.5 Gbps.

Table 3-14. Receive and Jitter Tolerance

Symbol	Description	Test Conditions	Min.	Тур.	Max.	Units
RL <sub>RX_DIFF</sub>	Differential return loss	From 100 MHz to 3.125 GHz	10	_	_	dB
RL <sub>RX_CM</sub>	Common mode return loss	From 100 MHz to 3.125 GHz	6	_	_	dB
Z <sub>RX_DIFF</sub>	Differential termination resistance		80	100	120	Ohms
J <sub>RX_DJ</sub> <sup>1, 2, 3</sup>	Deterministic jitter tolerance (peak-to-peak)		_	_	0.37	UI
J <sub>RX_RJ</sub> <sup>1, 2, 3</sup>	Random jitter tolerance (peak-to-peak)		_	_	0.18	UI
J <sub>RX_SJ</sub> <sup>1, 2, 3</sup>	Sinusoidal jitter tolerance (peak-to-peak)		_	_	0.10	UI
J <sub>RX_TJ</sub> <sup>1, 2, 3</sup>	Total jitter tolerance (peak-to-peak)		_	_	0.65	UI
T <sub>RX_EYE</sub>	Receiver eye opening		0.35	_	_	UI

- 1. Total jitter includes deterministic jitter, random jitter and sinusoidal jitter. The sinusoidal jitter tolerance mask is shown in Figure 3-18.
- 2. Jitter values are measured with each high-speed input AC coupled into a 50-Ohm impedance.
- 3. Jitter and skew are specified between differential crossings of the 50% threshold of the reference signal.
- 4. Jitter tolerance parameters are characterized when Full Rx Equalization is enabled.
- 5. Values are measured at 2.5 Gbps.



# SMPTE SD/HD-SDI/3G-SDI (Serial Digital Interface) Electrical and Timing Characteristics

#### **AC and DC Characteristics**

#### Table 3-19. Transmit

Symbol	Description	Test Conditions	Min.	Тур.	Max.	Units
BR <sub>SDO</sub>	Serial data rate		270	_	2975	Mbps
T <sub>JALIGNMENT</sub> <sup>2</sup>	Serial output jitter, alignment	270 Mbps	_	_	0.20	UI
T <sub>JALIGNMENT</sub> <sup>2</sup>	Serial output jitter, alignment	1485 Mbps	_	_	0.20	UI
T <sub>JALIGNMENT</sub> <sup>1, 2</sup>	Serial output jitter, alignment	2970Mbps	_	_	0.30	UI
T <sub>JTIMING</sub>	Serial output jitter, timing	270 Mbps	_	_	0.20	UI
T <sub>JTIMING</sub>	Serial output jitter, timing	1485 Mbps	_	_	1.0	UI
T <sub>JTIMING</sub>	Serial output jitter, timing	2970 Mbps	_	_	2.0	UI

#### Notes:

- Timing jitter is measured in accordance with SMPTE RP 184-1996, SMPTE RP 192-1996 and the applicable serial data transmission standard, SMPTE 259M-1997 or SMPTE 292M (proposed). A color bar test pattern is used. The value of f<sub>SCLK</sub> is 270 MHz or 360 MHz for SMPTE 259M, 540 MHz for SMPTE 344M or 1485 MHz for SMPTE 292M serial data rates. See the Timing Jitter Bandpass section.
- 2. Jitter is defined in accordance with SMPTE RP1 184-1996 as: jitter at an equipment output in the absence of input jitter.
- 3. All Tx jitter is measured at the output of an industry standard cable driver; connection to the cable driver is via a 50 Ohm impedance differential signal from the Lattice SERDES device.
- 4. The cable driver drives: RL=75 Ohm, AC-coupled at 270, 1485, or 2970 Mbps, RREFLVL=RREFPRE=4.75 kOhm 1%.

#### Table 3-20. Receive

Symbol	Description	Test Conditions	Min.	Тур.	Max.	Units
BR <sub>SDI</sub>	Serial input data rate		270	_	2970	Mbps
CID	Stream of non-transitions (=Consecutive Identical Digits)		7(3G)/26(SMPTE Triple rates) @ 10-12 BER	_	_	Bits

#### Table 3-21. Reference Clock

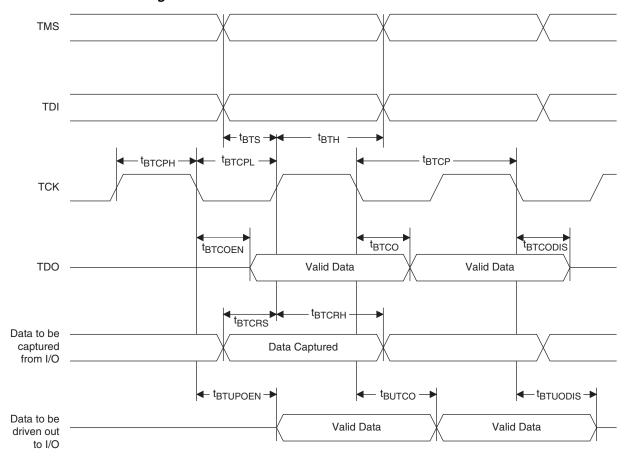
Symbol	Description	Test Conditions	Min.	Тур.	Max.	Units
F <sub>VCLK</sub>	Video output clock frequency		27	_	74.25	MHz
$DC_V$	Duty cycle, video clock		45	50	55	%



## **JTAG Port Timing Specifications**

Symbol	Parameter	Min	Max	Units
f <sub>MAX</sub>	TCK clock frequency	_	25	MHz
t <sub>BTCP</sub>	TCK [BSCAN] clock pulse width	40	_	ns
t <sub>BTCPH</sub>	TCK [BSCAN] clock pulse width high	20	_	ns
t <sub>BTCPL</sub>	TCK [BSCAN] clock pulse width low	20	_	ns
t <sub>BTS</sub>	TCK [BSCAN] setup time	10	_	ns
t <sub>BTH</sub>	TCK [BSCAN] hold time	8	_	ns
t <sub>BTRF</sub>	TCK [BSCAN] rise/fall time		_	mV/ns
t <sub>BTCO</sub>	TAP controller falling edge of clock to valid output	_	10	ns
t <sub>BTCODIS</sub>	TAP controller falling edge of clock to valid disable	_	10	ns
t <sub>BTCOEN</sub>	TAP controller falling edge of clock to valid enable	_	10	ns
t <sub>BTCRS</sub>	BSCAN test capture register setup time	8	_	ns
t <sub>BTCRH</sub>	BSCAN test capture register hold time	25	_	ns
t <sub>BUTCO</sub>	BSCAN test update register, falling edge of clock to valid output		25	ns
t <sub>BTUODIS</sub>	BSCAN test update register, falling edge of clock to valid disable	_	25	ns
t <sub>BTUPOEN</sub>	BSCAN test update register, falling edge of clock to valid enable	_	25	ns

Figure 3-32. JTAG Port Timing Waveforms





Part Number	Voltage	Grade <sup>1</sup>	Power	Package	Pins	Temp.	LUTs (K)
LFE3-70EA-6FN484C	1.2 V	-6	STD	Lead-Free fpBGA	484	COM	67
LFE3-70EA-7FN484C	1.2 V	<b>-</b> 7	STD	Lead-Free fpBGA	484	COM	67
LFE3-70EA-8FN484C	1.2 V	-8	STD	Lead-Free fpBGA	484	COM	67
LFE3-70EA-6LFN484C	1.2 V	-6	LOW	Lead-Free fpBGA	484	COM	67
LFE3-70EA-7LFN484C	1.2 V	-7	LOW	Lead-Free fpBGA	484	COM	67
LFE3-70EA-8LFN484C	1.2 V	-8	LOW	Lead-Free fpBGA	484	COM	67
LFE3-70EA-6FN672C	1.2 V	-6	STD	Lead-Free fpBGA	672	COM	67
LFE3-70EA-7FN672C	1.2 V	-7	STD	Lead-Free fpBGA	672	COM	67
LFE3-70EA-8FN672C	1.2 V	-8	STD	Lead-Free fpBGA	672	COM	67
LFE3-70EA-6LFN672C	1.2 V	-6	LOW	Lead-Free fpBGA	672	COM	67
LFE3-70EA-7LFN672C	1.2 V	-7	LOW	Lead-Free fpBGA	672	COM	67
LFE3-70EA-8LFN672C	1.2 V	-8	LOW	Lead-Free fpBGA	672	COM	67
LFE3-70EA-6FN1156C	1.2 V	-6	STD	Lead-Free fpBGA	1156	COM	67
LFE3-70EA-7FN1156C	1.2 V	-7	STD	Lead-Free fpBGA	1156	COM	67
LFE3-70EA-8FN1156C	1.2 V	-8	STD	Lead-Free fpBGA	1156	COM	67
LFE3-70EA-6LFN1156C	1.2 V	-6	LOW	Lead-Free fpBGA	1156	COM	67
LFE3-70EA-7LFN1156C	1.2 V	-7	LOW	Lead-Free fpBGA	1156	COM	67
LFE3-70EA-8LFN1156C	1.2 V	-8	LOW	Lead-Free fpBGA	1156	COM	67

<sup>1.</sup> For ordering information on -9 speed grade devices, please contact your Lattice Sales Representative.

Part Number	Voltage	Grade <sup>1</sup>	Power	Package	Pins	Temp.	LUTs (K)
LFE3-95EA-6FN484C	1.2 V	-6	STD	Lead-Free fpBGA	484	COM	92
LFE3-95EA-7FN484C	1.2 V	-7	STD	Lead-Free fpBGA	484	COM	92
LFE3-95EA-8FN484C	1.2 V	-8	STD	Lead-Free fpBGA	484	COM	92
LFE3-95EA-6LFN484C	1.2 V	-6	LOW	Lead-Free fpBGA	484	COM	92
LFE3-95EA-7LFN484C	1.2 V	-7	LOW	Lead-Free fpBGA	484	COM	92
LFE3-95EA-8LFN484C	1.2 V	-8	LOW	Lead-Free fpBGA	484	COM	92
LFE3-95EA-6FN672C	1.2 V	-6	STD	Lead-Free fpBGA	672	COM	92
LFE3-95EA-7FN672C	1.2 V	-7	STD	Lead-Free fpBGA	672	COM	92
LFE3-95EA-8FN672C	1.2 V	-8	STD	Lead-Free fpBGA	672	COM	92
LFE3-95EA-6LFN672C	1.2 V	-6	LOW	Lead-Free fpBGA	672	COM	92
LFE3-95EA-7LFN672C	1.2 V	-7	LOW	Lead-Free fpBGA	672	COM	92
LFE3-95EA-8LFN672C	1.2 V	-8	LOW	Lead-Free fpBGA	672	COM	92
LFE3-95EA-6FN1156C	1.2 V	-6	STD	Lead-Free fpBGA	1156	COM	92
LFE3-95EA-7FN1156C	1.2 V	-7	STD	Lead-Free fpBGA	1156	COM	92
LFE3-95EA-8FN1156C	1.2 V	-8	STD	Lead-Free fpBGA	1156	COM	92
LFE3-95EA-6LFN1156C	1.2 V	-6	LOW	Lead-Free fpBGA	1156	COM	92
LFE3-95EA-7LFN1156C	1.2 V	-7	LOW	Lead-Free fpBGA	1156	COM	92
LFE3-95EA-8LFN1156C	1.2 V	-8	LOW	Lead-Free fpBGA	1156	COM	92

<sup>1.</sup> For ordering information on -9 speed grade devices, please contact your Lattice Sales Representative.



#### Industrial

The following devices may have associated errata. Specific devices with associated errata will be notated with a footnote.

Part Number	Voltage	Grade	Power	Package <sup>1</sup>	Pins	Temp.	LUTs (K)
LFE3-17EA-6FTN256I	1.2 V	-6	STD	Lead-Free ftBGA	256	IND	17
LFE3-17EA-7FTN256I	1.2 V	-7	STD	Lead-Free ftBGA	256	IND	17
LFE3-17EA-8FTN256I	1.2 V	-8	STD	Lead-Free ftBGA	256	IND	17
LFE3-17EA-6LFTN256I	1.2 V	-6	LOW	Lead-Free ftBGA	256	IND	17
LFE3-17EA-7LFTN256I	1.2 V	-7	LOW	Lead-Free ftBGA	256	IND	17
LFE3-17EA-8LFTN256I	1.2 V	-8	LOW	Lead-Free ftBGA	256	IND	17
LFE3-17EA-6MG328I	1.2 V	-6	STD	Lead-Free csBGA	328	IND	17
LFE3-17EA-7MG328I	1.2 V	-7	STD	Lead-Free csBGA	328	IND	17
LFE3-17EA-8MG328I	1.2 V	-8	STD	Lead-Free csBGA	328	IND	17
LFE3-17EA-6LMG328I	1.2 V	-6	LOW	Green csBGA	328	IND	17
LFE3-17EA-7LMG328I	1.2 V	-7	LOW	Green csBGA	328	IND	17
LFE3-17EA-8LMG328I	1.2 V	-8	LOW	Green csBGA	328	IND	17
LFE3-17EA-6FN484I	1.2 V	-6	STD	Lead-Free fpBGA	484	IND	17
LFE3-17EA-7FN484I	1.2 V	-7	STD	Lead-Free fpBGA	484	IND	17
LFE3-17EA-8FN484I	1.2 V	-8	STD	Lead-Free fpBGA	484	IND	17
LFE3-17EA-6LFN484I	1.2 V	-6	LOW	Lead-Free fpBGA	484	IND	17
LFE3-17EA-7LFN484I	1.2 V	-7	LOW	Lead-Free fpBGA	484	IND	17
LFE3-17EA-8LFN484I	1.2 V	-8	LOW	Lead-Free fpBGA	484	IND	17

<sup>1.</sup> Green = Halogen free and lead free.

Part Number	Voltage	Grade <sup>1</sup>	Power	Package	Pins	Temp.	LUTs (K)
LFE3-35EA-6FTN256I	1.2 V	-6	STD	Lead-Free ftBGA	256	IND	33
LFE3-35EA-7FTN256I	1.2 V	-7	STD	Lead-Free ftBGA	256	IND	33
LFE3-35EA-8FTN256I	1.2 V	-8	STD	Lead-Free ftBGA	256	IND	33
LFE3-35EA-6LFTN256I	1.2 V	-6	LOW	Lead-Free ftBGA	256	IND	33
LFE3-35EA-7LFTN256I	1.2 V	-7	LOW	Lead-Free ftBGA	256	IND	33
LFE3-35EA-8LFTN256I	1.2 V	-8	LOW	Lead-Free ftBGA	256	IND	33
LFE3-35EA-6FN484I	1.2 V	-6	STD	Lead-Free fpBGA	484	IND	33
LFE3-35EA-7FN484I	1.2 V	-7	STD	Lead-Free fpBGA	484	IND	33
LFE3-35EA-8FN484I	1.2 V	-8	STD	Lead-Free fpBGA	484	IND	33
LFE3-35EA-6LFN484I	1.2 V	-6	LOW	Lead-Free fpBGA	484	IND	33
LFE3-35EA-7LFN484I	1.2 V	-7	LOW	Lead-Free fpBGA	484	IND	33
LFE3-35EA-8LFN484I	1.2 V	-8	LOW	Lead-Free fpBGA	484	IND	33
LFE3-35EA-6FN672I	1.2 V	-6	STD	Lead-Free fpBGA	672	IND	33
LFE3-35EA-7FN672I	1.2 V	-7	STD	Lead-Free fpBGA	672	IND	33
LFE3-35EA-8FN672I	1.2 V	-8	STD	Lead-Free fpBGA	672	IND	33
LFE3-35EA-6LFN672I	1.2 V	-6	LOW	Lead-Free fpBGA	672	IND	33
LFE3-35EA-7LFN672I	1.2 V	-7	LOW	Lead-Free fpBGA	672	IND	33
LFE3-35EA-8LFN672I	1.2 V	-8	LOW	Lead-Free fpBGA	672	IND	33

<sup>1.</sup> For ordering information on -9 speed grade devices, please contact your Lattice Sales Representative.



# LatticeECP3 Family Data Sheet Revision History

March 2015 Data Sheet DS1021

Date	Version	Section	Change Summary
March 2015	2.8EA	Pinout Information All	Updated Package Pinout Information section. Changed reference to http://www.latticesemi.com/Products/FPGAandCPLD/LatticeECP3.
			Minor style/formatting changes.
April 2014	02.7EA	DC and Switching	Updated LatticeECP3 Supply Current (Standby) table power numbers.
	Characteristics		Removed speed grade -9 timing numbers in the following sections:  — Typical Building Block Function Performance  — LatticeECP3 External Switching Characteristics  — LatticeECP3 Internal Switching Characteristics  — LatticeECP3 Family Timing Adders
		Ordering Information	Removed ordering information for -9 speed grade devices.
March 2014	02.6EA	DC and Switching Characteristics	Added information to the sysl/O Single-Ended DC Electrical Characteristics section footnote.
February 2014	02.5EA	DC and Switching Characteristics	Updated Hot Socketing Specifications table. Changed $I_{\text{PW}}$ to $I_{\text{PD}}$ in footnote 3.
			Updated the following figures:  — Figure 3-25, sysCONFIG Port Timing  — Figure 3-27, Wake-Up Timing
		Supplemental Information	Added technical note references.
September 2013	02.4EA	DC and Switching	Updated the Wake-Up Timing Diagram
		Characteristics	Added the following figures:  — Master SPI POR Waveforms  — SPI Configuration Waveforms  — Slave SPI HOLDN Waveforms
			Added tIODISS and tIOENSS parameters in LatticeECP3 sysCONFIG Port Timing Specifications table.
June 2013	02.3EA	Architecture	sysl/O Buffer Banks text section – Updated description of "Top (Bank 0 and Bank 1) and Bottom syslO Buffer Pairs (Single-Ended Outputs Only)" for hot socketing information.
			sysl/O Buffer Banks text section – Updated description of "Configuration Bank sysl/O Buffer Pairs (Single-Ended Outputs, Only on Shared Pins When Not Used by Configuration)" for PCI clamp information.
			On-Chip Oscillator section – clarified the speed of the internal CMOS oscillator (130 MHz +/- 15%).
			Architecture Overview section – Added information on the state of the register on power up and after configuration.
		DC and Switching Characteristics	sysl/O Recommended Operating Conditions table – Removed reference to footnote 1 from RSDS standard.
			sysl/O Single-Ended DC Electrical Characteristics table – Modified footnote 1.
			Added Oscillator Output Frequency table.
			LatticeECP3 sysCONFIG Port Timing Specifications table – Updated min. column for t <sub>CODO</sub> parameter.
			LatticeECP3 Family Timing Adders table – Description column, references to VCCIO = 3.0V changed to 3.3V. For PPLVDS, description changed from emulated to True LVDS and VCCIO = 2.5V changed to VCCIO = 2.5V or 3.3V.

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Date	Version	Section	Change Summary
September 2009	01.4	Architecture	Corrected link in sysMEM Memory Block section.
			Updated information for On-Chip Programmable Termination and modified corresponding figure.
			Added footnote 2 to On-Chip Programmable Termination Options for Input Modes table.
		Corrected Per Quadrant Primary Clock Selection figure.	
		DC and Switching Characteristics	Modified -8 Timing data for 1024x18 True-Dual Port RAM (Read-Before-Write, EBR Output Registers)
			Added ESD Performance table.
			LatticeECP3 External Switching Characteristics table - updated data for
			t <sub>DIBGDDR</sub> , t <sub>W_PRI</sub> , t <sub>W_EDGE</sub> and t <sub>SKEW_EDGE_DQS</sub> .
			LatticeECP3 Internal Switching Characteristics table - updated data for $t_{\text{COO\_PIO}}$ and added footnote #4.
			sysCLOCK PLL Timing table - updated data for f <sub>OUT</sub> .
			External Reference Clock Specification (refclkp/refclkn) table - updated data for $V_{\text{REF-IN-SE}}$ and $V_{\text{REF-IN-DIFF}}$
			LatticeECP3 sysCONFIG Port Timing Specifications table - updated data for t <sub>MWC</sub> .
			Added TRLVDS DC Specification table and diagram.
			Updated Mini LVDS table.
August 2009	01.3	DC and Switching Characteristics	Corrected truncated numbers for $V_{\text{CCIB}}$ and $V_{\text{CCOB}}$ in Recommended Operating Conditions table.
July 2009	01.2	Multiple	Changed references of "multi-boot" to "dual-boot" throughout the data sheet.
		Architecture	Updated On-Chip Programmable Termination bullets.
			Updated On-Chip Termination Options for Input Modes table.
			Updated On-Chip Termination figure.
		DC and Switching Characteristics	Changed min/max data for FREF_PPM and added footnote 4 in SERDES External Reference Clock Specification table.
			Updated SERDES minimum frequency.
		Pinout Information	Corrected MCLK to be I/O and CCLK to be I in Signal Descriptions table
May 2009	01.1	All	Removed references to Parallel burst mode Flash.
		Introduction	Features - Changed 250 Mbps to 230 Mbps in Embedded SERDES bulleted section and added a footnote to indicate 230 Mbps applies to 8b10b and 10b12b applications.
			Updated data for ECP3-17 in LatticeECP3 Family Selection Guide table.
			Changed embedded memory from 552 to 700 Kbits in LatticeECP3 Family Selection Guide table.
		Architecture	Updated description for CLKFB in General Purpose PLL Diagram.
			Corrected Primary Clock Sources text section.
			Corrected Secondary Clock/Control Sources text section.
			Corrected Secondary Clock Regions table.
			Corrected note below Detailed sysDSP Slice Diagram.
			Corrected Clock, Clock Enable, and Reset Resources text section.
			Corrected ECP3-17 EBR number in Embedded SRAM in the LatticeECP3 Family table.
			Added On-Chip Termination Options for Input Modes table.
1	1		Updated Available SERDES Quads per LatticeECP3 Devices table.